



Gaskell, J. and Eaves, L. and Novoselov, K.S. and Mishchenko, A. and Geim, A.K. and Fromhold, T.M. and Greenaway, M.T. (2015) Graphene-hexagonal boron nitride resonant tunneling diodes as high-frequency oscillators. *Applied Physics Letters*, 107 (10). 103105/1-103105/4. ISSN 1077-3118

Access from the University of Nottingham repository:

http://eprints.nottingham.ac.uk/35047/1/graphene-hBN-oscillations_Nottingham_rep.pdf

Copyright and reuse:

The Nottingham ePrints service makes this work by researchers of the University of Nottingham available open access under the following conditions.

This article is made available under the Creative Commons Attribution licence and may be reused according to the conditions of the licence. For more details see: <http://creativecommons.org/licenses/by/2.5/>

A note on versions:

The version presented here may differ from the published version or from the version of record. If you wish to cite this item you are advised to consult the publisher's version. Please see the repository url above for details on accessing the published version and note that access may require a subscription.

For more information, please contact eprints@nottingham.ac.uk

Graphene-hBN resonant tunneling diodes as high-frequency oscillators

J. Gaskell,¹ L. Eaves,^{1,2} K.S. Novoselov,² A. Mishchenko,² A.K. Geim,^{2,3} T.M. Fromhold,¹ and M.T. Greenaway¹

¹School of Physics and Astronomy, University of Nottingham, Nottingham, NG7 2RD, UK

²School of Physics and Astronomy, University of Manchester, Oxford Road, Manchester, M13 9PL, UK

³Centre for Mesoscience and Nanotechnology, University of Manchester, Manchester, M13 9PL, UK

(Dated: July 14, 2016)

We assess the potential of two-terminal graphene-hBN-graphene resonant tunneling diodes as high-frequency oscillators, using self-consistent quantum transport and electrostatic simulations to determine the time-dependent response of the diodes in a resonant circuit. We quantify how the frequency and power of the current oscillations depend on the diode and circuit parameters including the doping of the graphene electrodes, device geometry, alignment of the graphene lattices, and the circuit impedances. Our results indicate that current oscillations with frequencies of up to several hundred GHz should be achievable.

Paper published on 9th September 2015: *Applied Physics Letters* **107**, 103105 (2015), doi: 10.1063/1.4930230

Resonant tunneling diodes (RTDs) operating at 1.4 THz and 10 μ W output power have been demonstrated recently [1–3]. An addition to the family of RTDs is the graphene tunnel transistor [4–15], in which negative differential conductance (NDC), with a room temperature peak-to-valley ratio of 2:1, arises from constraints imposed by energy and momentum conservation of Dirac Fermions which tunnel through a boron nitride (hBN) barrier [6, 7].

Here, we analyse how the device and circuit parameters can be tuned to increase the operating frequency of graphene resonant tunneling diodes (GRTDs). Our model device, shown schematically in Fig. 1(a), comprises two graphene layers separated by a hBN tunnel barrier of thickness, d . The bottom (B) and top (T) graphene electrodes are arranged in an overlapping cross formation, resulting in a tunneling area, $A = 1 \mu\text{m}^2$. We consider the general case when the two graphene crystalline lattices are slightly misorientated by a twist angle, θ , see Fig. 1(a). The tunnel current is particularly sensitive to this angle [7]. A voltage, V_b , applied between top and bottom graphene layers [Fig. 1(b)] induces a charge density, $\rho_{B,T}$, in each layer and causes a tunnel current, I_b , to flow through the hBN barrier. The graphene layers, with in-plane sheet resistance, R , carry current, I , (black arrows) from two pairs of Ohmic contacts [orange in Fig. 1(a)] to the central active (tunneling) region of the device, i.e. currents, $I/2$, flow to/from each contact. The electrostatics [4] are governed by the equation $eV_b = \mu_B - \mu_T + \phi_b$, where $\phi_b = eF_b d$ and F_b is the electric field in the barrier, e is the magnitude of the electronic charge, and $\mu_{B,T}$ are the two Fermi levels [see Fig. 1(b)].

A device with NDC provides instability that can generate self-sustained current oscillations when placed in an RLC circuit [16, 17]. To investigate the frequency response of the GRTD, we solve the time-dependent current continuity and Poisson equations self-consistently, using the Bardeen transfer Hamiltonian method to cal-

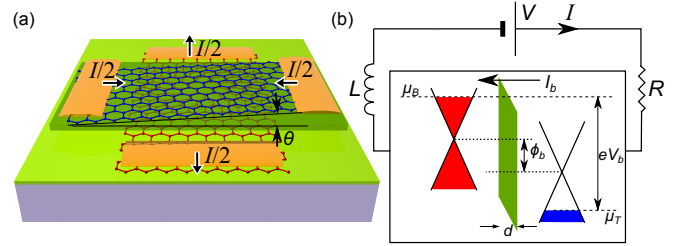


FIG. 1. (a) Schematic diagram of the GRTD comprising bottom (red) and top (blue) graphene lattices, misaligned by an angle θ and separated by a hBN tunnel barrier (dark green). The current, I , passes through the tunnel barrier between the graphene electrode layers to/from Ohmic contacts (orange). The diode is mounted on a hBN layer (light green) and an insulating substrate (purple). (b) Schematic diagram of the resonant circuit incorporating the GRTD (in box) showing the voltage applied, V , circuit inductance, L , and resistance, R . The band diagram is shown (box), with electrostatic parameters defined in the text.

culate the tunnel current,

$$I_b = \frac{8\pi e}{\hbar} \sum_{\mathbf{k}_B, \mathbf{k}_T} |M|^2 [f_B(E_B) - f_T(E_T)] \delta(E_B - E_T - \phi_b), \quad (1)$$

as a function of time, t , and V_b . The summation is over all initial and final states, with wavevectors, $\mathbf{k}_{B,T}$, measured relative to the position of the nearest Dirac point in the bottom layer, $\mathbf{K}_B^\pm = (\pm 4\pi/3a_0, 0)$, where \pm distinguishes the two non-equivalent Dirac points in the Brillouin zone and $a_0 = 2.46 \text{ \AA}$ is the graphene lattice constant. The Fermi function in each electrode is $f_{B,T}(E_{B,T}) = [1 + e^{(E_{B,T} - \mu_{B,T})/kT}]^{-1}$ where $E_{B,T} = s_{B,T} \hbar v_F k_{B,T}$ is the electron energy and $s_{B,T} = \pm 1$ labels electrons in the conduction (+) and valence (-) bands, at temperature $T = 300 \text{ K}$. Tunneling between equivalent valleys gives the same contribution to the tunnel current, so we consider transitions between \mathbf{K}^+ points only. In Eq. (1) the matrix element, M , is

$$M = \Xi \gamma(\theta) g(\varphi_B, \varphi_T) V_S(\mathbf{q} - \Delta \mathbf{K}), \quad (2)$$

where $\Xi = \xi e^{-\kappa d}$, ξ is a normalisation constant deter-

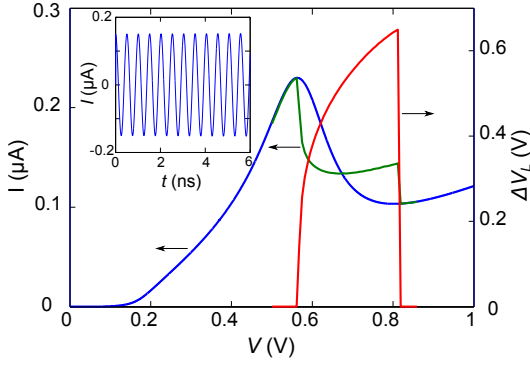


FIG. 2. Equilibrium and non-equilibrium current-voltage curves calculated for $\theta = 0.9^\circ$, $L = 140$ nH and $R = 50$ Ω . Blue: equilibrium current-voltage characteristic $I_b(V_b)$. Note, in equilibrium, $V_b \approx V$ and $I_b = I$. Green: time-averaged current $\langle I(t) \rangle_t$ vs V . Red: peak-to-peak voltage amplitude (right scale) of the stable current oscillations. Inset: $I(t)$ plot showing stable oscillations with $f = 4.2$ GHz.

mined by comparison with recent measurements [7] of I_b , $\gamma(\theta)$ is the spatial overlap integral of the cell-periodic part of the wavefunction, $g(\varphi_B, \varphi_T)$ describes electron chirality, V_S is the elastic scattering potential, and $\mathbf{q} = \mathbf{k}_B - \mathbf{k}_T$ (see below). The decay constant of the wavefunction in the barrier is $\kappa = \sqrt{2m\Delta_b}/\hbar$, where the barrier height, $\Delta_b = 1.5$ eV, and the effective electron mass in the barrier $m = 0.5m_e$ [4].

In recently-studied GRTDs [7], the crystal lattices of the two graphene layers are only misorientated by an angle $\theta \approx 1^\circ$. Nevertheless, this gives rise to a significant misalignment of the Dirac cones of the two layers, $\Delta\mathbf{K} = (R(\theta) - \mathbb{I})\mathbf{K}^+$, where $R(\theta)$ is the 2D rotation matrix. When $\theta < 2^\circ$, $|\mathbf{q}| \approx |\Delta\mathbf{K}| = \Delta K$ and electrons tunnel with conservation of in-plane momentum. However, tunneling electrons can scatter elastically from impurities and defects, broadening the features in the $I_b(V_b)$ curves [18, 19]. Therefore, we use a scattering potential $V_S(q) = V_0/(q^2 + q_c^2)$, with amplitude $V_0 = 10$ meV and length scale $1/q_c = 15$ nm, which gives the best fit in the region of the resonant peak and NDC. The misorientation also reduces the spatial overlap integral, $\gamma(\theta)$. The chiral wavefunctions give rise to the term $g(\varphi_B, \varphi_T) = 1 + s_B e^{i\varphi_B} + s_T e^{-i\varphi_T} + s_B s_T e^{i(\varphi_B - \varphi_T)}$, where $\varphi = \tan^{-1}(k_y/k_x)$ is the orientation of the wavevector.

Fig. 2 shows the equilibrium (static) $I_b(V_b)$ curve (blue), where $V_b \approx V$ and $I_b = I$, calculated for an undoped device with $\theta = 0.9^\circ$ and $d = 1.3$ nm (4 layers of hBN), similar to that studied in [7]. The calculated $I_b(V_b)$ curve reproduces the measured line-shape, position of the resonant peak and current amplitude [6, 7]. The peak occurs when many electrons can tunnel with momentum conservation, i.e. $\mathbf{q} - \Delta\mathbf{K} \sim 0$, corresponding to a resonant increase in the matrix element M , i.e. when $\phi_b = \hbar v_F \Delta K$ for θ close to 1° . Temperature has negligible effect on the $I(V_b)$ curve when $V_b > kT/e \sim 30$

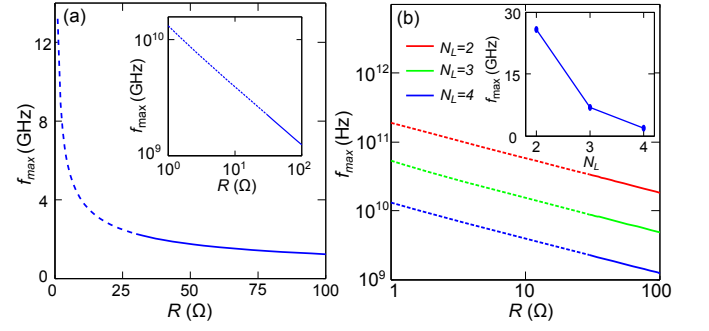


FIG. 3. (a) $f_{max}(R)$ calculated when $N_L = 4$. Inset: Log-log plot. (b) f_{max} vs R when $N_L = 2$ (red), 3 (green) and 4 (blue). Inset: f_{max} vs N_L calculated when $R = 50$ Ω . Curves are shown solid over the range of R presently obtainable in GRTDs and dashed for R values that could be achieved by future device designs. All curves are for undoped devices.

mV [6, 7].

We now consider the non-equilibrium charge dynamics when the device is in a series circuit with inductance, L , and resistance, R , see Fig. 1(b); the diode has an in-built capacitance, C . The device has no in-built inductance and therefore, to oscillate, requires a series inductance. Recently, self-excited plasma oscillations have also been shown to cause instabilities and oscillations in GRTDs [15]. The primary contribution to R arises from the graphene electrodes [4] and depends on the charge densities, $\rho_{B,T}$. This dependence does not significantly affect the high-frequency (HF) response: for most of the oscillation period, changes in $\rho_{B,T}$ do not greatly affect R . Therefore, we take R to be independent of t . However, R can be changed by altering the device geometry, e.g. by reducing the length of the electrodes, and we consider this effect on the performance of the GRTD. We also consider how L affects the frequency, which could be controlled by careful design of the microwave circuit, e.g. by using a resonant cavity or integrated patch antennas [2].

We determine the current, $I(t)$, in the contacts and external circuit by solving [20] self-consistently the current-continuity equations: $d\rho_{B,T}/dt = \pm(I_b - I)/A$, where the $+$ ($-$) sign is for the bottom (top) graphene layers, see Fig. 1(b), $\rho_{B,T}$ are related by Poisson's equation: $\epsilon F_b = \rho_B - \rho_{BD} = -(\rho_T - \rho_{TD})$, in which $\epsilon = \epsilon_0 \epsilon_r$ and $\epsilon_r = 3.9$ [4, 21] is the permittivity of the barrier, and ρ_{BD} (ρ_{TD}) are the doping densities in each layer. The voltages across the inductor and resistor, V_L and V_R , are given by $dI/dt = V_L/L$, $V_R = IR$, and $V = V_R + V_b + V_L$.

Following initial transient behavior, $I(t)$ either decays to a constant value or oscillates with a frequency, f , and time-averaged current, $\langle I(t) \rangle_t$. Fig. 2, inset, shows a typical $I(t)$ curve, for $V = 0.48$ V, exhibiting oscillations with $f = 4.2$ GHz. In Fig. 2, we show $\langle I(t) \rangle_t$ versus V (green) and $I_b(V_b)$ (blue curve) for an undoped device, with $\theta = 0.9^\circ$, placed in a resonant circuit with $R = 50$ Ω and $L = 140$ nH. The plot reveals that when V is tuned in the NDC region (0.55 V $< V < 0.8$ V), $\Delta V_L = V_L^{max} -$

V_L^{\min} (red curve) becomes non-zero indicating that self-sustained oscillations are induced. Here, $V_L^{\max/\min}$ is the maximum/minimum voltage dropped across the inductor during an oscillation period. Also, the $\langle I(t) \rangle_t$ versus V curve (green) diverges from the static current, $I_b(V_b)$, (blue) in the NDC region. This is due to asymmetric rectification of $I(t)$ in the strongly nonlinear NDC region of $I_b(V_b)$. When the device is biased in regions of positive differential conductance, i.e. $V < 0.55$ V or $V > 0.8$ V, oscillations are suppressed and $\langle I(t) \rangle_t$ converges to $I_b(V_b)$.

This behavior is similar to that recently measured in a GRTD, where oscillations with $f \sim 2$ MHz were reported [7]. That device had high circuit capacitance due to large-area contact pads and coupling to the doped Si substrate (gate). This effect can be modelled by placing a capacitor in parallel with the GRTD. Including this large capacitance (65 pF) limits the maximum observed f value [7]. When parasitic circuit capacitances are minimised, using the geometry shown in Fig. 1(a), the only significant contribution to the total capacitance is from the graphene electrodes, as described by the charge-continuity equation. This enables us to investigate the potential of GRTDs optimised for HF applications.

A small signal analysis [16] provides insight into how L , R , and the form of $I_b(V_b)$ affect the circuit response and gives an approximate frequency:

$$f^s = f_0 \sqrt{(1 - R/R_N) - Q_N^{-2} (1 - Q_N^2 R/R_N)^2 / 4}, \quad (3)$$

where R_N is the maximum negative differential resistance of the equilibrium $I(V)$ curve, the circuit factor $Q_N = R_N \sqrt{C/L}$, and $f_0 = 1/2\pi\sqrt{LC}$. Here, R_N is large and therefore $f^s \approx f_0$. For a given C (that depends on A and d), the frequency can be increased by reducing L . The decay parameter of the small signal analysis reveals that the circuit will oscillate only if

$$(R_N/R - Q_N^2) > 0. \quad (4)$$

Consequently, R , and the shape of the static $I_b(V_b)$ curve are also important for optimising the HF performance.

We now consider the self-consistent simulation of the charge dynamics. Fig. 3(a) shows the $f_{max}(R)$ curve calculated for the diode parameters, which compare well to recent measurements [7], used to produce the $I_b(V_b)$ curves in Fig. 2. We determine $f_{max}(R)$ by finding the smallest L value for self-sustained oscillations. The solid part of the curve in Fig. 3(a) shows f_{max} over the range of R values that can be achieved with small modifications to the design of existing devices, e.g. by reducing the length of the graphene between the tunnel area and the Ohmic contacts, or by doping the electrodes. The dashed part is calculated for R values that may be possible in future configurations. The curve reveals that for a recently-attained $R = 50 \Omega$ [22, 23], $f_{max} = 1.8$ GHz.

Fig. 3(a), inset, reveals the power law $f_{max} \propto R^{-0.505}$, which can be derived by setting Eq. (4) equal to zero

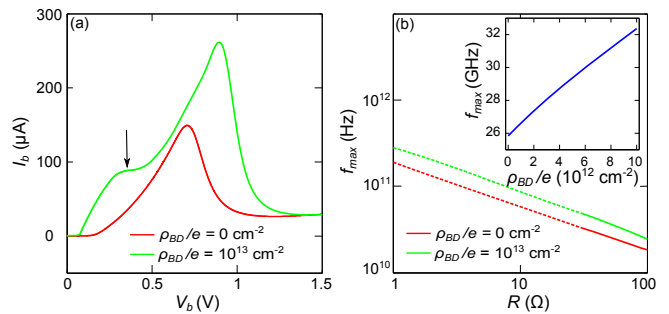


FIG. 4. (a) $I_b(V_b)$ characteristics calculated for a doped (green, $\rho_{BD}/e = 10^{13} \text{ cm}^{-2}$) and undoped (red) device, with $N_L = 2$. The arrow shows the shoulder that arises due to the quantum capacitance effect. (b) f_{max} vs R curves for the devices in (a). Inset: f_{max} vs (ρ_{BD}/e) calculated when $R = 50 \Omega$, with $\rho_{TD}/e = 0$. Curves in (b) are shown solid over the range of R presently obtainable in GRTDs and dashed for R values that could be achieved by future device designs.

and rearranging to find the smallest L value for a given R , R_N , and C [16]. For this case

$$f_{max}^s = (2\pi C \sqrt{RR_N})^{-1} \propto R^{-0.5}, \quad (5)$$

which compares well with the full signal analysis.

To increase f_{max} , we can also modify $I_b(V_b)$. Reducing the number of layers, N_L , in the hBN tunnel barrier increases I_b ($\sim 20\times$ for each layer removed [24]) thus reducing R_N and increasing f_{max} , see Eq. (5). Fig. 3(b) shows $f_{max}(R)$ calculated for a device with $N_L = 4$ (blue), 3 (green) and 2 (red). Reducing d produces a large gain in f_{max} for all R . For example, f_{max} for a device with $N_L = 2$ is at least an order of magnitude higher than when $N_L = 4$ (e.g. for $R = 50 \Omega$, $f_{max} = 26$ GHz when $N_L = 2$, compared to $f_{max} = 1.8$ GHz when $N_L = 4$).

The $I_b(V_b)$ characteristics can also be modified by doping the graphene chemically [25, 26] or, equivalently, by applying a gate voltage, V_g , to shift the current peak and, thereby, change R_N and the peak to valley ratio [6, 7]. In Fig. 4(a), we show $I_b(V_b)$ curves calculated when $N_L = 2$ for an undoped (red curve) and an asymmetrically-doped device with $\rho_{BD}/e = 10^{13} \text{ cm}^{-2}$ and $\rho_{TD}/e = 0$ (green curve). When $\rho_{BD} > 0$, the resonant peak occurs at higher V_b than when $\rho_{BD} = 0$, and the current peak magnitude is higher, raising the PVR from 1.5 to 3.5.

The shoulder of the green curve in Fig. 4(a), (arrowed) when $\rho_{BD}/e = 10^{13} \text{ cm}^{-2}$, arises from the low density of states around the Dirac point. This gives rise to an additional quantum capacitance [6, 27], C_Q , whose effect is prominent when the chemical potential in one layer aligns with the Dirac point in the other layer. The total capacitance is given by $C^{-1} = C_G^{-1} + C_Q^{-1}$, where $C_G = \epsilon_0 \epsilon_r A/d$ is the geometric capacitance. When $\mu_{B,T}$ passes through the Dirac point, $C_Q \rightarrow 0$ and, hence, $C \rightarrow 0$, suggesting that the RC time constant of the device could be reduced. In practice, C_Q is small for only a small fraction of the oscillation period and so its effect on the fundamental frequency of $I(t)$ is negligible.

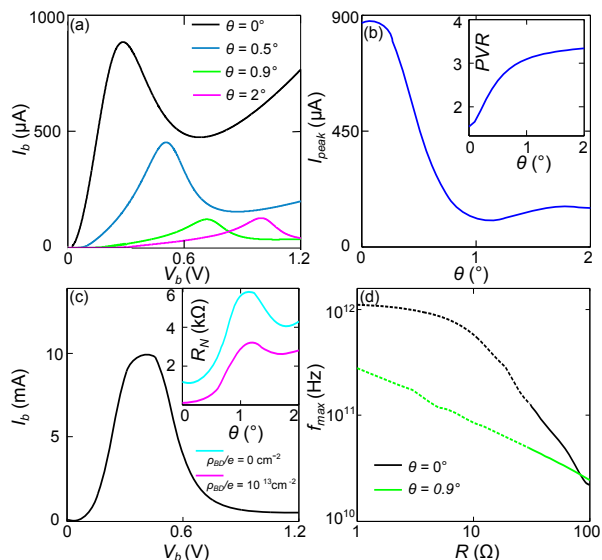


FIG. 5. (a) $I_b(V_b)$ curves calculated for samples with misalignment angles $\theta = 0^\circ$ (black), 0.5° (blue), 0.9° (green), 2° (magenta), taking $\rho_{BD}/e = 0 \text{ cm}^{-2}$ and $N_L = 2$. (b) Current amplitude at the peak vs misalignment angle, θ . Inset: PVR of $I_b(V_b)$ vs θ . (c) $I_b(V_b)$ calculated when $\theta = 0^\circ$ and $\rho_{BD}/e = 10^{13} \text{ cm}^{-2}$. Inset: $R_N(\theta)$ for undoped (upper) and $\rho_{BD}/e = 10^{13} \text{ cm}^{-2}$ (lower) diodes. (d) f_{max} vs R curves calculated for an aligned sample (black) and misaligned sample with $\theta = 0.9^\circ$ (green), when $\rho_{BD}/e = 10^{13} \text{ cm}^{-2}$. Curves are shown solid over the range of R presently obtainable in GRTDs and dashed for R values that could be achieved by future device designs. For all curves, $\rho_{TD}/e = 0 \text{ cm}^{-2}$.

Fig. 4(b) shows $f_{max}(R)$ curves calculated for undoped (red) and doped (green) devices and reveals that the doped device is faster for all R . Fig. 4(b) inset shows that f_{max} increases monotonically with ρ_{BD}/e when $R = 50 \Omega$; f_{max} increases by a factor of 1.25 when ρ_{BD}/e is increased to 10^{13} cm^{-2} (and $f = 32 \text{ GHz}$) from $\rho_{BD}/e = 0$ ($f = 26 \text{ GHz}$).

To quantify the possible benefits of lattice alignment, Fig. 5(a) shows the effect of changing θ on $I_b(V_b)$. As θ increases, the position of the current peak shifts to higher V_b . The peak current amplitude, I_{peak} , decreases as θ increases due to increasing misorientation of the spatial parts of the wavefunction, see Fig. 5(b), so that I_{peak} could be $\sim 10\times$ larger for an aligned device. However,

for undoped samples, the PVR increases with increasing θ , see inset in Fig. 5(b), converging to a value of 3.4 as θ approaches 2° : at higher θ , more states are available to tunnel resonantly at the current peak [10]. For the doped samples ($\rho_{BD}/e = 10^{13} \text{ cm}^{-2}$), the valley current is close to 0 for all θ , thus the PVR is consistently large, see Fig. 5(c). Consequently, the increase in current magnitude, which results from alignment, leads to higher f values without the power reduction associated with undoped samples. We find that, generally, $R_N \propto 1/f_{max}^s$; Eq. (6) decreases with decreasing θ , Fig. 5(c) inset, and with increasing ρ_{BD} , meaning that f is highest for $\theta = 0^\circ$ and when $\rho_{BD} = 0$. Fig. 5(d) shows that perfect alignment could increase f_{max} by a factor of ~ 2 , i.e. for $R = 50 \Omega$, $f_{max} = 65 \text{ GHz}$ when $\theta = 0^\circ$ compared to 32 GHz when $\theta = 0.9^\circ$. The numerical results diverge from the small signal analysis power law of $f_{max} \propto R^{-0.5}$ as R_N becomes small, see black curve of Fig. 5(d), and it becomes necessary to vary V to induce oscillations.

In conclusion, we have investigated the performance of GRTDs as the active element in RLC oscillators. These devices could oscillate at mid-GHz frequencies, by careful design of the RLC circuit. We have also quantified the effect of changing the parameters of the GRTD. Reducing the barrier width (a modest change to the structure of existing devices) increases the tunnel current, and thus raises the oscillation frequency by an order of magnitude. Adjusting the doping of the electrodes can enhance f . Finally, we have considered the effect of misalignment of the graphene electrodes: in devices with aligned lattices, frequencies approaching 1 THz may be attainable. GaAsInAs/AlAs RTDs [1] with $N_L = 2$ barriers have similar I_b and V_b values as the GRTD reported here. We therefore expect that the GRTD will produce similar EM emission power ($\sim 10 \mu\text{W}$). Our results illustrate the potential of graphene tunnel structures in HF graphene electronics.

ACKNOWLEDGEMENTS

This work is supported by the EU Graphene Flagship Programme. K.S.N. and M.T.G. acknowledge the support of the Royal Society and of The Leverhulme Trust, respectively.

[1] S. Suzuki, M. Asada, A. Teranishi, H. Asugiyama, and H. Yokoyama, *Appl. Phys. Lett.* **97**, 242102 (2010).
 [2] Y. Koyama, R. Sekiguchi, and T. Ouchi, *Appl. Phys. Express* **6**, 064102 (2013).
 [3] M. Feiginov, H. Kanaya, S. Suzuki and M. Asada *Appl. Phys. Lett.* **104**, 243509 (2014).
 [4] L. Britnell, R.V. Gorbachev, R. Jalil, B.D. Belle, F. Schedin, A. Mishchenko, T. Georgiou, M.I. Katsnelson, L. Eaves, S.V. Morozov, N.M.R. Peres, J. Leist, A.K.

Geim, K.S. Novoselov, and L.A. Ponomarenko, *Science* **335**, 947 (2012).
 [5] T. Georgiou, R. Jalil, B. D. Belle, L. Britnell, R. V. Gorbachev, S. V. Morozov, Y. J. Kim, A. Gholinia, S. J. Haigh, O. Makarovskiy, L. Eaves, L. A. Ponomarenko, A. K. Geim, K. S. Novoselov, and A. Mishchenko *Nat. Nano.* **2**, 100-103 (2013).
 [6] L. Britnell, R.V. Gorbachev, A.K. Geim, L.A. Ponomarenko, A. Mishchenko, M.T. Greenaway, T.M.

- Fromhold, K.S. Novoselov, and L. Eaves, *Nat. Commun.* **4**, 1794 (2013).
- [7] A. Mishchenko, J.S. Tu, Y. Cao, R.V. Gorbachev, J.R. Wallbank, M.T. Greenaway, V.E. Morozov, S.V. Morozov, M.J. Zhu, S.L. Wong, F. Withers, C.R. Woods, Y.-J. Kim, K. Watanabe, T. Taniguchi, E.E. Vdovin, O. Makarovskiy, T.M. Fromhold, V.I. Fal'ko, A.K. Geim, L. Eaves, and K.S. Novoselov, *Nat. Nano.* **9**, 808-813 (2014).
- [8] B. Fallahazad, K. Lee, S. Kang, J. Xue, S. Larentis, C. Corbet, K. Kim, H. C. P. Movva, T. Taniguchi, K. Watanabe, L. F. Register, S. K. Banerjee, and E. Tutuc, *Nano. Lett.* **15**, 428 (2015).
- [9] S. Kang, B. Fallahazad, L. Kayoung, H. Movva, K. Kyounghwan, C.M. Corbet, T. Taniguchi, K. Watanabe, L. Colombo, L.F. Register, E. Tutuc, and S.K. Banerjee, *IEEE Electron Device Lett.* **36**(4), 405-407 (2015).
- [10] R.M. Feenstra, D. Jena, and G. Gu *J. Appl. Phys.* **111**, 043711 (2012).
- [11] P. Zhao, R.M. Feenstra, G. Gu, and D. Jena, *IEEE Trans. Electron Devices* **60**, 951957 (2013).
- [12] L. Brey, *Phys. Rev. Applied* **2**, 014003 (2014).
- [13] F.T. Vasko, *Phys. Rev. B* **87**, 075424 (2013).
- [14] V. Ryzhii, A.A. Dubinov, V.Y. Aleshkin, M. Ryzhii and T. Otsuji *Appl. Phys. Lett.* **103**, 163507 (2013).
- [15] V. Ryzhii, A. Satou, T. Otsuji, M. Ryzhii, V. Mitin and M.S. Shur *J. Phys. D: Appl. Phys.* **46** 315107 (2013).
- [16] M.E. Hines, *Bell System Technical Journal* **39**, 477 (1960).
- [17] H. Mizuta and T. Tanoue, *The Physics and Applications of Resonant Tunneling Diodes*, Cambridge University Press (1995).
- [18] S. Adam, *et al.*, *Solid State Commun.* **149**, 1072 (2009)
- [19] Q. Li, *et al.*, *Phys. Rev. Lett.* **107**, 156601 (2011)
- [20] M. T. Greenaway, A. G. Balanov, E. Schöll, and T. M. Fromhold, *Phys. Rev. B* **80**, 205318 (2009).
- [21] K. Kim, A. Hsu, X. Jia, S. Kim, Y. Shi, M. Dresselhaus, T. Palacios and, J. Kong, *ACS Nano.* **6**(10), 8583-8590 (2012).
- [22] A. V. Kretinin, Y. Cao, J. S. Tu, G. L. Yu, R. Jalil, K. S. Novoselov, S. J. Haigh, A. Gholinia, A. Mishchenko, M. Lozada, T. Georgiou, C. R. Woods, F. Withers, P. Blake, G. Eda, A. Wirsig, C. Hucho, K. Watanabe, T. Taniguchi, A. K. Geim, and R. V. Gorbachev *Nano. Lett.* **14**, 3270-3276 (2014).
- [23] L. Wang, I. Meric, P. Y. Huang, Q. Gao, Y. Gao, H. Tran, T. Taniguchi, K. Watanabe, L. M. Campos, D. A. Muller, J. Guo, P. Kim, J. Hone, K. L. Shepard, and C. R. Dean *Science* **342**, 614-617 (2013).
- [24] L. Britnell, R.V. Gorbachev, R. Jalil, B.D. Belle, F. Schedin, M.I. Katsnelson, L. Eaves, S. V. Morozov, A.S. Mayorov, N.M.R. Peres, A.H. Castro Neto, J. Leist, A.K. Geim, L.A. Ponomarenko, and K.S. Novoselov, *Nano. Lett.* **12**(3), 1707-1710 (2012).
- [25] A. Das, S. Pisana, B. Chakraborty, S. Piscanec, S.K. Saha, U.V. Waghmare, K.S. Novoselov, H.R. Krishnamurthy, A.K. Geim, A. C. Ferrari, and A.K. Sood, *Nat. Nano.* **3**, 210-215 (2008).
- [26] L. Hongtao, L. Yunqi, and Z. Daoben, *J. Mat. Chem.* **21**(10), 3253-3496 (2011).
- [27] S. Luryi, *Appl. Phys. Lett.* **52**(6), 501-503 (1988).